

FDT3612

100V N-Channel PowerTrench® MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

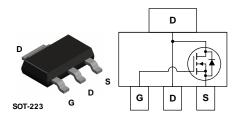
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\rm DS(ON)}$ specifications. The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

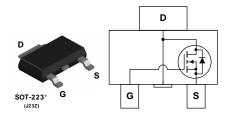
Applications

- DC/DC converter
- · Motor driving

Features

- 3.7 A, 100 V. $R_{DS(ON)}$ = 120 m Ω @ V_{GS} = 10 V $R_{DS(ON)}$ = 130 m Ω @ V_{GS} = 6 V
- · Fast switching speed
- Low gate charge (14nC typ)
- High performance trench technology for extremely low $R_{\mbox{\scriptsize DS(ON)}}$
- High power and current handling capability in a widely used surface mount package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|--------------------------------------------------|-----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 100 | V |
| V_{GSS} | Gate-Source Voltage | | ±20 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 3.7 | А |
| | - Pulsed | | 20 | |
| P _D | Maximum Power Dissipation | (Note 1a) | 3.0 | W |
| | | (Note 1b) | 1.3 | |
| | | (Note 1c) | 1.1 | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 42 | °C/W |
|-----------------|-----------------------------------------|-----------|----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 12 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|---------|-----------|------------|------------|
| 3612 | FDT3612 | 13" | 12mm | 2500 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------------------|---------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----------------|-------------------|-------|
| Drain-So | ource Avalanche Ratings (Note | 2) | | I | ı | I |
| W _{DSS} | Drain-Source Avalanche Energy | Single Pulse, $V_{DD} = 50 \text{ V}$, $I_D = 3.7 \text{ A}$ | | | 90 | mJ |
| I _{AR} | Drain-Source Avalanche Current | | | | 3.7 | Α |
| Off Char | acteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 100 | | | V |
| <u>ΔBV_{DSS}</u> ΔT _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | 106 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 80 \text{ V}, \qquad V_{GS} = 0 \text{ V}$ | | | 10 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 2 | 2.5 | 4 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | -6 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $V_{GS} = 10 \text{ V}, \qquad I_D = 3.7 \text{ A}$ $V_{GS} = 6 \text{ V}, \qquad I_D = 3.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 3.7 \text{A}, T_J = 125^{\circ}\text{C}$ | | 88 94 170 | 120 130 245 | mΩ |
| I _{D(on)} | On-State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ | 10 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, \qquad I_{D} = 3.7 \text{ A}$ | | 11 | | S |
| Dvnamio | Characteristics | | | | | I |
| C _{iss} | Input Capacitance | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$ | | 632 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 40 | | pF |
| C _{rss} | Reverse Transfer Capacitance | 7 | | 20 | | pF |
| Switchin | g Characteristics (Note 2) | | | ı | | ı |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 50 \text{ V}, \qquad I_D = 1 \text{ A},$ | | 8.5 | 17 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$ | | 2 | 4 | ns |
| t _{d(off)} | Turn-Off Delay Time | 7 | | 23 | 37 | ns |
| t _f | Turn-Off Fall Time | 7 | | 4.5 | 9 | ns |
| Qg | Total Gate Charge | $V_{DS} = 50 \text{ V}, \qquad I_{D} = 3.7 \text{ A},$ | | 14 | 20 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = 10 V | | 2.4 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 3.8 | | nC |
| Drain-Se | ource Diode Characteristics | and Maximum Ratings | | | | |
| Is | Maximum Continuous Drain–Source | | | | 2.5 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 2.5 \text{ A}$ (Note 2) | | 0.75 | 1.2 | V |

Notes

R_{QJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{QJC} is guaranteed by design while R_{QCA} is determined by the user's board design.



a) 42°C/W when mounted on a 1in² pad of 2 oz copper



b) 95°C/W when mounted on a .0066 in² pad of 2 oz copper



c) 110°C/W when mounted on a minimum pad.

Typical Characteristics

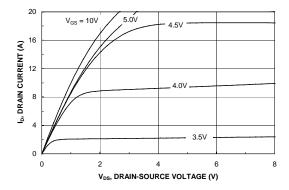


Figure 1. On-Region Characteristics.

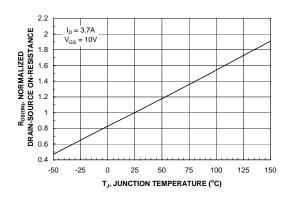


Figure 3. On-Resistance Variation with Temperature.

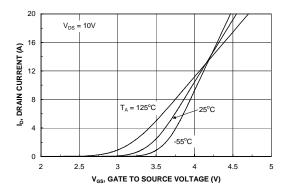


Figure 5. Transfer Characteristics.

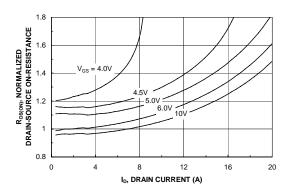


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

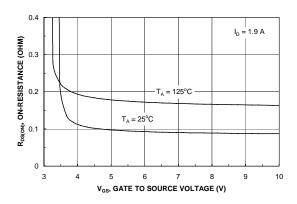


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

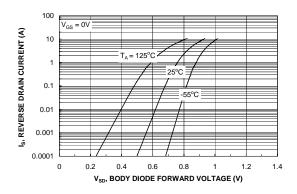
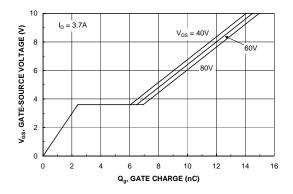


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics

ID, DRAIN CURRENT (A)



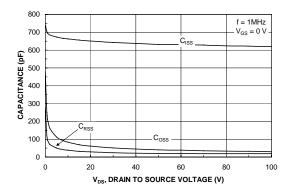


Figure 7. Gate Charge Characteristics.

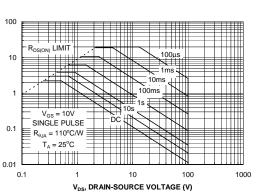


Figure 8. Capacitance Characteristics.

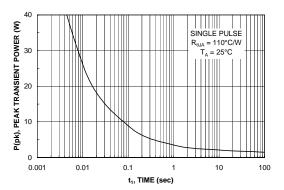


Figure 9. Maximum Safe Operating Area.



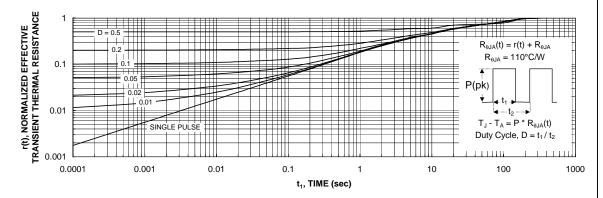


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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